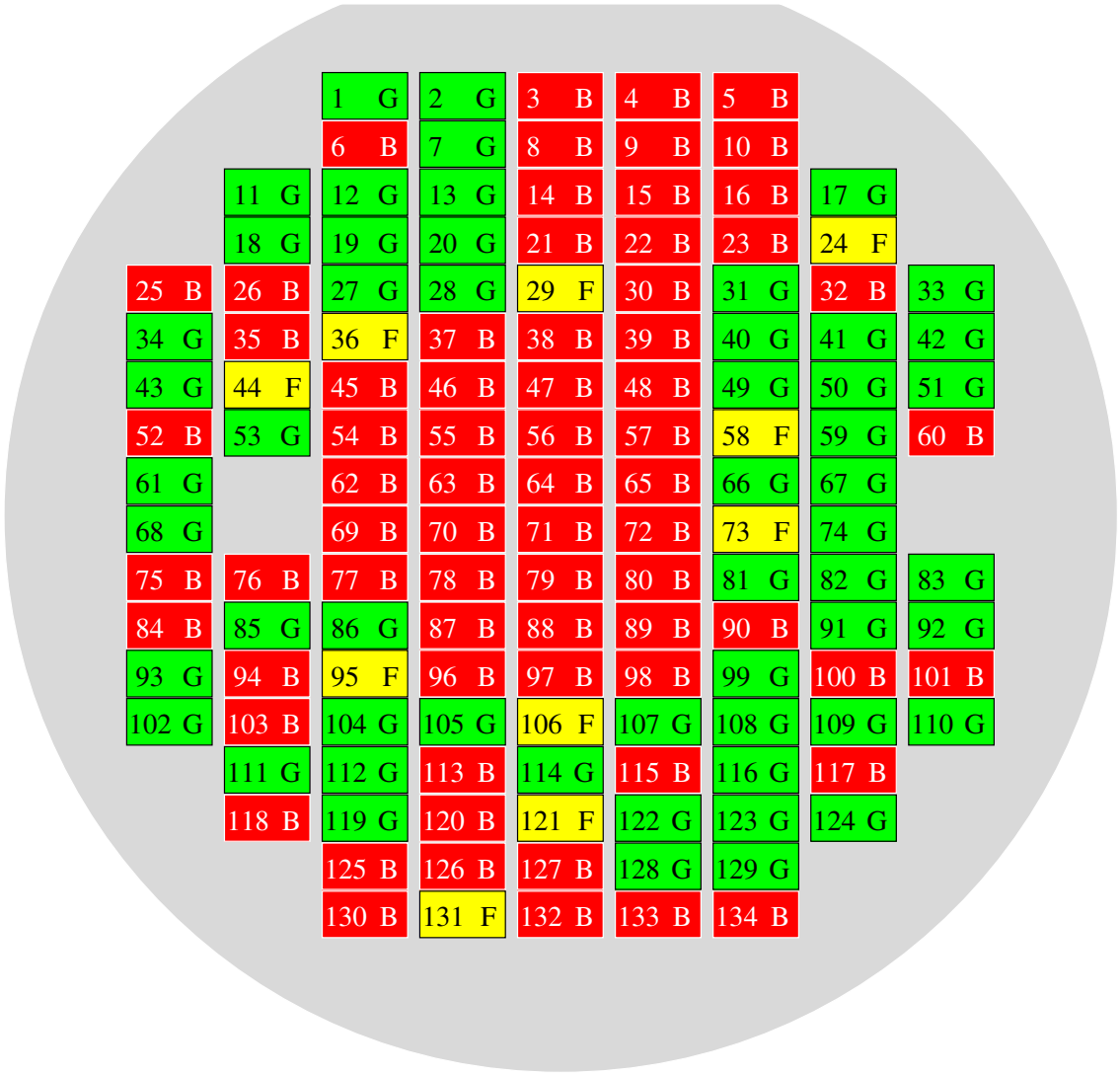
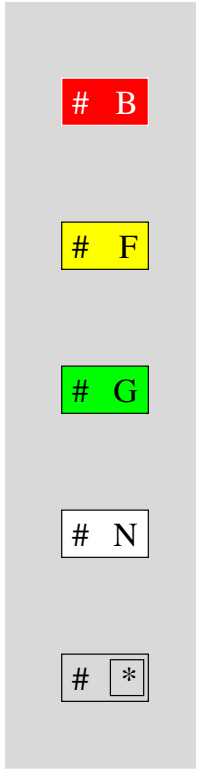
Die quality map for wafer 82 s/n: Y21316-12-11 (annealed 1 week)

Date: 05/03/99





Bad die

Fair die

Good die

No info

Manually tagged